ANALOG DEVICES

High Accuracy ±1 *g* to ±5 *g* Single Axis *i*MEM**S**® Accelerometer with Analog Input

ADXL105*

FEATURES
Monolithic IC Chip
2 m*g* Resolution
10 kHz Bandwidth
Flat Amplitude Response (±1%) to 5 kHz
Low Bias and Sensitivity Drift
Low Power 2 mA
Output Ratiometric to Supply
User Scalable *g* Range
On-Board Temperature Sensor
Uncommitted Amplifier
Surface Mount Package
+2.7 V to +5.25 V Single Supply Operation
1000 *g* Shock Survival

APPLICATIONS
Automotive
Accurate Tilt Sensing with Fast Response
Machine Health and Vibration Measurement
Affordable Inertial Sensing of Velocity and Position
Seismic Sensing
Rotational Acceleration

FUNCTIONAL BLOCK DIAGRAM

GENERAL DESCRIPTION

The ADXL105 is a high performance, high accuracy and complete single-axis acceleration measurement system on a single monolithic IC. The ADXL105 offers significantly increased bandwidth and reduced noise versus previously available micromachined devices. The ADXL105 measures acceleration with a full-scale range up to ±5 *g* and produces an analog voltage output. Typical noise floor is 225 $\mu g \sqrt{\text{Hz}}$ allowing signals below 2 m*g* to be resolved. A 10 kHz wide frequency response enables vibration measurement applications. The product exhibits significant reduction in offset and sensitivity drift over temperature compared to the ADXL05.

The ADXL105 can measure both dynamic accelerations, (typical of vibration) or static accelerations (such as inertial force, gravity or tilt).

Output scale factors from 250 mV/*g* to 1.5 V/*g* are set using the on-board uncommitted amplifier and external resistors. The device features an on-board temperature sensor with an output of 8 mV/°C for optional temperature compensation of offset vs. temperature for high accuracy application.

The ADXL105 is available in a hermetic 14-lead surface mount Cerpak with versions specified for the 0°C to +70°C, and –40°C to +85°C temperature ranges.

*Patent Pending.
*i*MEM**S** is a registered trademark of Analog Devices, Inc.

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ADXL105–SPECIFICATIONS

$(T_A = T_{MIN}$ to T_{MAX}, $T_A = +25°C$ for J Grade Only, $V_S = +5$ V, @ Acceleration = 0 g, unless otherwise noted)

Parameter	Conditions	ADXL105J/A Min	Typ	Max	Units
SENSOR INPUT					
Measurement Range[1]		±5	±7		g
Nonlinearity	Best Fit Straight Line		0.2		% of FS
Alignment Error[2]			±1		Degrees
Cross Axis Sensitivity[3]	Z Axis, @ +25°C		±1	±5	%
SENSITIVITY[4] (Ratiometric)	At A_{OUT}				
Initial		225	250	275	mV/g
	$V_S = 2.7$ V	80	105	120	mV/g
vs. Temperature[5, 6]			±0.5		%
ZERO g BIAS LEVEL[5] (Ratiometric)	At A_{OUT}				
Zero g Offset Error	From +2.5 V Nominal	−625		+625	mV
vs. Supply		−20		+20	mV/V_{DD}/V
vs. Temperature[5, 7]			50		mV
NOISE PERFORMANCE					
Voltage Density[7]	@ +25°C		225	325	$\mu g/\sqrt{Hz}$
Noise in 100 Hz Bandwidth			2.25		mg rms
FREQUENCY RESPONSE					
3 dB Bandwidth		10	12		kHz
Sensor Resonant Frequency		13	18		kHz
TEMP SENSOR[4] (Ratiometric)					
Output Error at +25°C	From +2.5 V Nominal	−100		+100	mV
Nominal Scale Factor			8		mV/°C
Output Impedance			10		kΩ
V_{MID}[4] (Ratiometric)					
Output Error	From +2.5 V Nominal	−15		+15	mV
Output Impedance			10		kΩ
SELF-TEST (Proportional to V_{DD})					
Voltage Delta at A_{OUT}	Self-Test "0" to "1"	100		500	mV
Input Impedance[8]		30	50		kΩ
A_{OUT}					
Output Drive	I = ± 50 µA	0.50		$V_S − 0.5$	V
Capacitive Load Drive		1000			pF
UNCOMMITTED AMPLIFIER					
Initial Offset		−25		+25	mV
Initial Offset vs. Temperature			5		µV/°C
Common-Mode Range		1.0		4.0	V
Input Bias Current[9]			25		nA
Open Loop Gain			100		V/mV
Output Drive	I = ±100 µA	0.25		$V_S − 0.25$	V
Capacitive Load Drive		1000			pF
POWER SUPPLY					
Operating Voltage Range		2.70		5.25	V
Quiescent Supply Current	At 5.0 V		1.9	2.6	mA
	At 2.7 V		1.3	2.0	mA
Turn-On Time			700		µs
TEMPERATURE RANGE					
Operating Range J		0		+70	°C
Specified Performance A		−40		+85	°C

NOTES

[1]Guaranteed by tests of zero g bias, sensitivity and output swing.

[2]Alignment of the X axis is with respect to the long edge of the bottom half of the Cerpak package.

[3]Cross axis sensitivity is measured with an applied acceleration in the Z axis of the device.

[4]This parameter is ratiometric to the supply voltage V_{DD}. Specification is shown with a 5.0 V V_{DD}. To calculate approximate values at another V_{DD}, multiply the specification by $V_{DD}/5$ V.

[5]Specification refers to the maximum change in parameter from its initial value at +25°C to its worst case value at T_{MIN} to T_{MAX}.

[6]See Figure 3.

[7]See Figure 2.

[8]CMOS and TTL Compatible.

[9]UCA input bias current is tested at final test.

All min and max specifications are guaranteed. Typical specifications are not tested or guaranteed.

Specifications subject to change without notice.

ABSOLUTE MAXIMUM RATINGS*

Acceleration (Any Axis, Unpowered for 0.5 ms) . . . . . . 1000 g
Acceleration (Any Axis, Powered for 0.5 ms) . . . . 500 g
+V_S . . . . –0.3 V to +7.0 V
Output Short Circuit Duration
   (Any Pin to Common) . . . . Indefinite
Operating Temperature . . . . –55°C to +125°C
Storage Temperature . . . . –65°C to +150°C

*Stresses above those listed under Absolute Maximum Ratings may cause perma-
nent damage to the device. This is a stress rating only; the functional operation of
the device at these or any other conditions above those indicated in the operational
sections of this specification is not implied. Exposure to absolute maximum rating
conditions for extended periods may affect device reliability.

Package Characteristics

Package	θ_{JA}	θ_{JC}	Device Weight
14-Lead Cerpak	110°C/W	30°C/W	<2 Grams

ORDERING GUIDE

Model	Temperature Range	Package Option
ADXL105JQC	0°C to +70°C	QC-14
ADXL105AQC	–40°C to +85°C	QC-14

CAUTION

ESD (electrostatic discharge) sensitive device. Electrostatic charges as high as 4000 V readily
accumulate on the human body and test equipment and can discharge without detection.
Although the ADXL105 features proprietary ESD protection circuitry, permanent damage may
occur on devices subjected to high energy electrostatic discharges. Therefore, proper ESD
precautions are recommended to avoid performance degradation or loss of functionality.
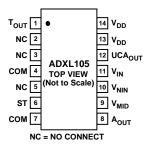
WARNING!

ESD SENSITIVE DEVICE

Drops onto hard surfaces can cause shocks of greater than 1000 g
and exceed the absolute maximum rating of the device. Care should
be exercised in handling to avoid damage.

PIN FUNCTION DESCRIPTIONS

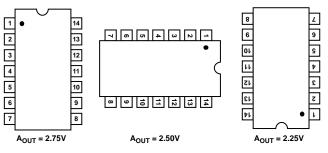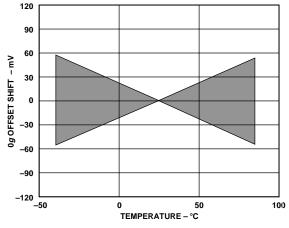| Pin No.	Name	Description
1	T_{OUT}	Temperature Sensor Output
2, 3, 5	NC	No Connect
4	COM	Common
6	ST	Self-Test
7	COM	Common (Substrate)
8	A_{OUT}	Accelerometer Output
9	V_{MID}	V_{DD}/2 Reference Voltage
10	V_{NIN}	Uncommitted Amp Noninverting Input
11	V_{IN}	Uncommitted Amp Inverting Input
12	UCA_{OUT}	Uncommitted Amp Output
13, 14	V_{DD}	Power Supply Voltage

PIN CONFIGURATION

Figure 1. ADXL105 Response Due to Gravity

ADXL105–Typical Performance Characteristics
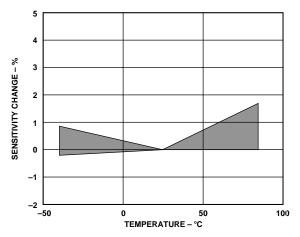
Figure 2. Typical 0 g Shift vs. Temperature*
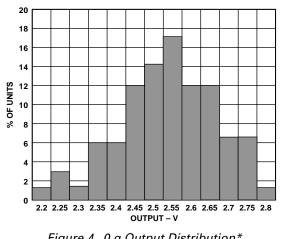
Figure 3. Typical Sensitivity Shift vs. Temperature*
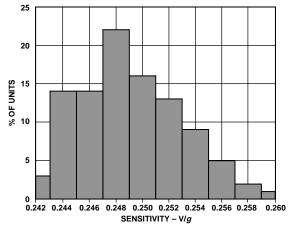
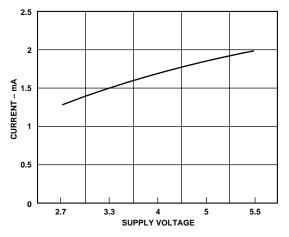Figure 4. 0 g Output Distribution*

Figure 5. Sensitivity Distribution*
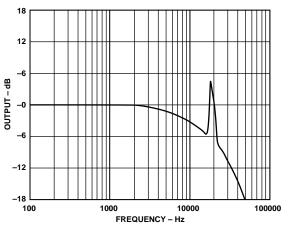
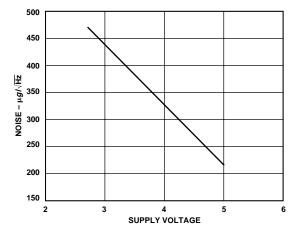Figure 6. Typical Supply Current vs. Supply Voltage

Figure 7. Noise Graph

*Data from several characterization lots.

Figure 8. Typical Noise Density vs. Supply Voltage

Figure 11. Typical Self-Test Response at V_{DD} = 5 V

Figure 9. Noise Distribution*

Figure 12. Frequency Response

Figure 10. Rotational Die Alignment*

Figure 13. Phase Response

*Data from several characterization lots.
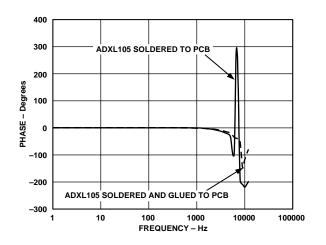
ADXL105

THEORY OF OPERATION

The ADXL105 is a complete acceleration measurement system on a single monolithic IC. It contains a polysilicon surface-micromachined sensor and BiMOS signal conditioning circuitry to implement an open loop acceleration measurement architecture. The ADXL105 is capable of measuring both positive and negative accelerations to a maximum level of $\pm 5\ g$. The accelerometer also measures static acceleration such as gravity, allowing it to be used as a tilt sensor.

The sensor is a surface micromachined polysilicon structure built on top of the silicon wafer. Polysilicon springs suspend the structure over the surface of the wafer and provide a resistance against acceleration-induced forces. Deflection of the structure is measured with a differential capacitor structure that consists of two independent fixed plates and a central plate attached to the moving mass. A 180° out-of-phase square wave drives the fixed plates. An acceleration causing the beam to deflect, will unbalance the differential capacitor resulting in an output square wave whose amplitude is proportional to acceleration. Phase sensitive demodulation techniques are then used to rectify the signal and determine the direction of the acceleration.

An uncommitted amplifier is supplied for setting the output scale factor, filtering and other analog signal processing.

A ratiometric voltage output temperature sensor measures the exact die temperature and can be used for optional calibration of the accelerometer over temperature.

V_{DD}

The ADXL105 has two power supply (V_{DD}) pins, 13 and 14. The two pins should be connected directly together. The output of the ADXL105 is ratiometric to the power supply. Therefore a 0.22 µF decoupling capacitor between V_{DD} and COM is required to reduce power supply noise. To further reduce noise, insert a resistor (and/or a ferrite bead) in series with the V_{DD} pin. See the EMC and Electrical Noise section for more details.

COM

The ADXL105 has two common (COM) pins, 4 and 7. These two pins should be connected directly together and Pin 7 grounded.
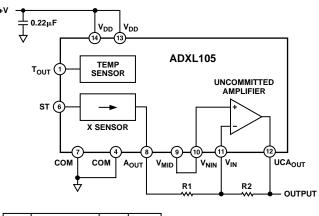
ST

The ST pin (Pin 6) controls the self-test feature. When this pin is set to V_{DD}, an electrostatic force is exerted on the beam of the accelerometer causing the beam to move. The change in output resulting from movement of the beam allows the user to test for mechanical and electrical functionality. This pin may be left open-circuit or connected to common in normal use. The self-test input is CMOS and TTL compatible.

A_{OUT}

The accelerometer output (Pin 8) is set to a nominal scale factor of 250 mV/g (for V_{DD} = 5 V). Note that A_{OUT} is guaranteed to source/sink a minimum of 50 µA (approximately 50 kΩ output impedance). So a buffer may be required between A_{OUT} and some A-to-D converter inputs.
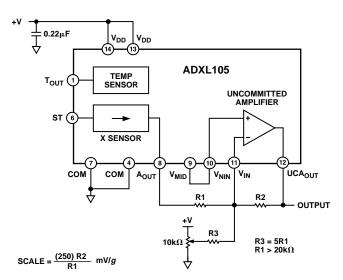
V_{MID}

V_{MID} is nominally V_{DD}/2. It is primarily intended for use as a reference output for the on board uncommitted amplifier (UCA) as shown in Figures 14a and 14b. Its output impedance is approximately 10 kΩ.

GAIN	SCALE – mV/g	R1	R2
1	250	50kΩ	50kΩ
2	500	50kΩ	100kΩ
3	750	50kΩ	150kΩ
4	1000	50kΩ	200kΩ

a. Using the UCA to Change the Scale Factor

$$SCALE = \frac{(250)\ R2}{R1}\ mV/g$$

b. Using the UCA to Change the Scale Factor and Zero g Bias

Figure 14. Application Circuit for Increasing Scale Factor

T_{OUT}
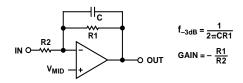
The temperature sensor output is nominally 2.5 V at +25°C and typically changes 8 mV/°C, and is optimized for repeatability rather than accuracy. The output is ratiometric with supply voltage.
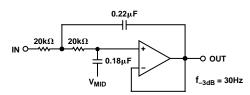
Uncommitted Amplifier (UCA)

The uncommitted amplifier has a low noise, low drift bipolar front end design. The UCA can be used to change the scale factor of the ADXL105 as shown in Figure 14. The UCA may also be used to add a 1- or 2-pole active filter as shown in Figures 15a through 15d.
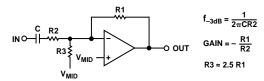
Output Scaling

The acceleration output (A_{OUT}) of the ADXL105 is nominally 250 mV/g. This scale factor may not be appropriate for all applications. The UCA may be used to increase the scale factor. The simplest implementation would be as shown in Figure 14a. Since the 0 g offset of the ADXL105 is 2.5 V ± 625 mV, using a gain of greater than 4 could result in having the UCA output at 0 V or 5 V at 0 g. The solution is to add R3 and VR1, as shown in Figure 14b, turning the UCA into a summing amplifier. VR1 is adjusted such that the UCA output is V_{DD}/2 at 0 g.
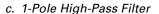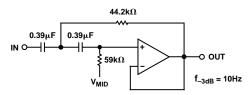
$$f_{-3dB} = \frac{1}{2\pi CR1}$$

$$GAIN = -\frac{R1}{R2}$$

a. 1-Pole Low-Pass Filter

$$f_{-3dB} = 30Hz$$

b. 2-Pole Bessel Low-Pass Filter

$$f_{-3dB} = \frac{1}{2\pi CR2}$$

$$GAIN = -\frac{R1}{R2}$$

$$R3 \approx 2.5\ R1$$

c. 1-Pole High-Pass Filter

$$f_{-3dB} = 10Hz$$

d. 2-Pole Bessel High-Pass Filter

Figure 15. UCA Used as Active Filters*

Device Bandwidth vs. Resolution

In general the bandwidth selected will determine the noise floor and hence, the measurement resolution (smallest detectable acceleration) of the ADXL105. Since the noise of the ADXL105 has the characteristic of white Gaussian noise that contributes equally at all frequencies, the noise amplitude may be reduced by simply reducing the bandwidth. So the typical noise of the ADXL105 is:

$$Noise\ (rms) = (225\ \mu g/\sqrt{Hz}) \times (\sqrt{Bandwidth \times K})$$

Where

$K \approx 1.6$ for a single-pole filter

$K \approx 1.4$ for a 2-pole filter

So given a bandwidth of 1000 Hz, the typical rms noise floor of an ADLX105 will be:

Noise $= (225\ \mu g/\sqrt{Hz}) \times (\sqrt{1000 \times 1.6})$

= 9 mg rms for a single-pole filter

and

Noise $= (225\ \mu g/\sqrt{Hz}) \times (\sqrt{1000 \times 1.4})$

= 8.4 mg rms for 2-pole filter

Often the peak value of the noise is desired. Peak-to-peak noise can only be estimated by statistical means. Table I may be used for estimating the probabilities of exceeding various peak values given the rms value. The peak-to-peak noise value will give the best estimate of the uncertainty in a single measurement.

Table I. Estimation of Peak-to-Peak Noise

Nominal Peak-to-Peak Value	% of Time that Noise Will Exceed Peak-to-Peak Value
2 × rms	32%
3 × rms	13%
4 × rms	4.6%
5 × rms	1.2%
6 × rms	0.27%
7 × rms	0.047%
8 × rms	0.0063%

The UCA may be configured to act as an active filter with gain and 0 g offset control as shown in Figure 16.
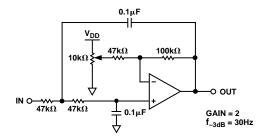
$$GAIN = 2$$
$$f_{-3dB} = 30Hz$$

Figure 16. UCA Configured as an Active Low-Pass Filter with Gain and Offset

EMC and Electrical Noise

The design of the ADXL105 is such that EMI or magnetic fields do not normally affect it. Since the ADXL105 is ratiometric, conducted electrical noise on V_{DD} does affect the output. This is particularly true for noise at the ADXL105's internal clock frequency (200 kHz) and its odd harmonics. So maintaining a clean supply voltage is key in preserving the low noise and high resolution properties of the ADXL105.

One way to ensure that V_{DD} contains no high frequency noise is to add an R-C low-pass filter near the V_{DD} pin as shown in Figure 17. Using the component values shown in Figure 17, noise at 200 kHz is attenuated by approximately –23 dB. Assuming the ADXL105 consumes 2 mA, there will be a 100 mV drop across R1. This can be neglected simply by using the ADXL105's V_{DD} as the A-to-D converter's reference voltage as shown in Figure 17.

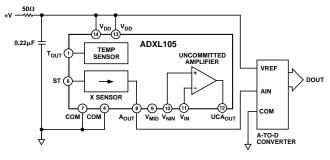*For other corner frequencies, consult an active filter handbook.

ADXL105

Figure 17. Reducing Noise on V_{DD}

Dynamic Operation
In applications where only dynamic accelerations (vibration) are of interest, it is often best to ac-couple the accelerometer output as shown in Figures 15c and 15d. The advantage of ac coupling is that 0g offset variability (part to part) and drifts are eliminated.

Low Power Operation
The most straightforward method of lowering the ADXL105's power consumption is to minimize its supply voltage. By lowering V_{DD} from 5 V to 2.7 V the power consumption goes from 9.5 mW to 3.5 mW. There may be reasons why lowering the supply voltage is impractical in many applications, in which case the best way to minimize power consumption is by power cycling.

The ADXL105 is capable of turning on and giving an accurate reading within 700 μs (see Figure 18). Most microcontrollers can perform an A-to-D conversion in under 25 μs. So it is practical to turn on the ADXL105 and take a reading in under 750 μs. Given a 100 Hz sample rate the average current required at 2.7 V would be:

$$100\ samples/s \times 750\ \mu s \times 1.3\ mA = 97.5\ \mu A$$
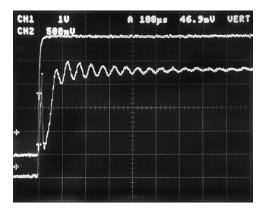

Figure 18. Typical Turn-On Response at V_{DD} = 5 V

Note that if a filter is used in the UCA, sufficient time must be allowed for the settling of the filter as well.

Broadband Operation
The ADXL105 has a number of characteristics that permits operation over a wide frequency range. Its frequency and phase response is essentially flat from dc to 10 kHz (see Figures 12 and 13). Its sensitivity is also constant over temperature (see Figure 3). In contrast, most accelerometers do not have linear response at low frequencies (in many cases, no response at very low frequencies or dc), and often have a large sensitivity temperature coefficient that must be compensated for. In addition, the ADXL105's noise floor is essentially flat from dc to

5 kHz where it gently rolls off (see Figure 7). The beam resonance at 16 kHz can be seen in Figure 7 where there is a small noise peak (+5 dB) at the beam's resonant frequency. There are no other significant noise peaks at any frequency.

The resonant frequency of the beam in the ADXL105 determines its high frequency limit. However the resonant frequency of the Cerpak package is typically around 7 kHz. As a result, it is not unusual to see 6 dB peaks occurring at the package resonant frequency (as shown in Figures 12 and 13). Indeed, the PCB will often have one or more resonant peaks well below 7 kHz. Therefore, if the application calls for accurate operation at or above 6 kHz the ADXL105 should be glued to the PCB in order to eliminate the amplitude response peak due to the package, and careful consideration should be given to the PCB mechanical design.

CALIBRATING THE ADXL105
The initial value of the offset and scale factor for the ADXL105 will require dc calibration for applications such as tilt measurement.

For low g applications, the force of gravity is the most stable, accurate and convenient acceleration reference available. An approximate reading of the 0 g point can be determined by orienting the device parallel to the Earth's surface and then reading the output. For high accuracy, a calibrated fixture must be used to ensure exact 90 degree orientation to the 1 g gravity signal.

An accurate sensitivity calibration method is to make a measurement at +1 g and –1 g. The sensitivity can be determined by the two measurements. This method has the advantage of being less sensitive to the alignment of the accelerometer because the on axis signal is proportional to the Cosine of the angle. For example, a 5° error in the orientation results in only a 0.4% error in the measurement.

To calibrate, the accelerometer measurement axis is pointed directly at the Earth. The 1 g reading is saved and the sensor is turned 180° to measure –1 g. Using the two readings and sensitivity is calculated:

$$Sensitivity = [1\ g\ Reading - (-1\ g\ Reading)]/2\ V/g$$

OUTLINE DIMENSIONS
Dimensions shown in inches and (mm).

14-Lead Cerpak
(QC-14)